

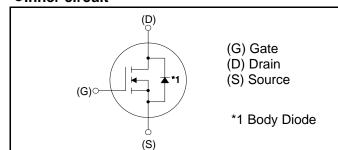
$V_{DSS}$	1200V
R <sub>DS(on)</sub> (Typ.)	160m $\Omega$
I <sub>D</sub>	22A* <sup>1</sup>

S2306

#### Features

- 1) Low on-resistance
- 2) Fast switching speed
- 3) Fast reverse recovery
- 4) Easy to parallel
- 5) Simple to drive

### •Inner circuit



## Application

- Solar inverters
- DC/DC converters
- Switch mode power supplies
- · Induction heating
- Motor drives

### ● Absolute maximum ratings (T<sub>a</sub> = 25°C)

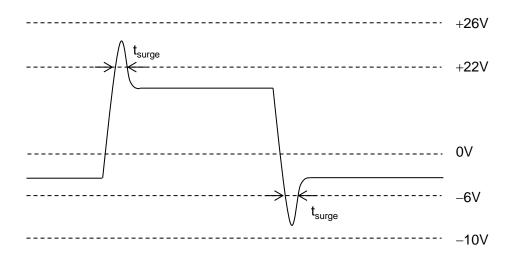
Parameter	Symbol	Value	Unit		
Drain - Source voltage		$V_{DSS}$	1200	V	
Continuous drain current	T <sub>c</sub> = 25°C	I <sub>D</sub> *1	22	А	
Pulsed drain current		I <sub>D,pulse</sub> *2	55	А	
Gate - Source voltage (DC)		$V_{GSS}$	−6 to 22	V	
Gate - Source surge voltage (T <sub>surge</sub> < 300nsec)		V <sub>GSS-surge</sub> *3	-10 to 26	V	
Junction temperature		T <sub>j</sub>	175	°C	
Range of storage temperature		T <sub>stg</sub>	-55 to +175	°C	

## ●Electrical characteristics (T<sub>a</sub> = 25°C)

Parameter	Symbol	Conditions	Values			Unit
raiailletei			Min.	Тур.	Max.	Offic
Drain - Source breakdown voltage	$V_{(BR)DSS}$	$V_{GS} = 0V$ , $I_D = 1mA$	1200	-	-	V
		$V_{DS} = 1200V, V_{GS} = 0V$				
Zero gate voltage drain current	$I_{DSS}$	T <sub>j</sub> = 25°C	-	1	10	μΑ
		T <sub>j</sub> = 150°C	-	2	-	
Gate - Source leakage current	I <sub>GSS+</sub>	$V_{GS} = +22V, V_{DS} = 0V$	-	-	100	nA
Gate - Source leakage current	I <sub>GSS-</sub>	$V_{GS} = -6V, V_{DS} = 0V$	-	-	-100	nA
Gate threshold voltage	V <sub>GS (th)</sub>	$V_{DS} = V_{GS}$ , $I_D = 2.5 \text{mA}$	1.6	2.8	4.0	V
		$V_{GS} = 18V$ , $I_D = 7A$				
Static drain - source on - state resistance	R <sub>DS(on)</sub> *4	T <sub>j</sub> = 25°C	-	160	198	mΩ
		T <sub>j</sub> = 125°C	-	226	-	
Gate input resistance	$R_{G}$	f = 1MHz, open drain	-	13.7	-	Ω

<sup>\*1</sup> Limited only by maximum temperature allowed.

<sup>\*3</sup> Example of acceptable Vgs waveform



\*4 Pulsed

<sup>\*2</sup> PW  $\leq$  10  $\mu s,$  Duty cycle  $\leq$  1%

# ●Electrical characteristics (T<sub>a</sub> = 25°C)

Doromotor	Cumbal	Conditions	Values			Linit
Parameter	Symbol	Conditions	Min.	Тур.	Max.	Unit
Transconductance	g <sub>fs</sub> *4	$V_{DS} = 10V, I_D = 7A$	-	2.4	-	S
Input capacitance	C <sub>iss</sub>	V <sub>GS</sub> = 0V	-	1200	-	
Output capacitance	C <sub>oss</sub>	V <sub>DS</sub> = 800V	-	45	-	pF
Reverse transfer capacitance	C <sub>rss</sub>	f = 1MHz	-	7	-	
Effective output capacitance, energy related	C <sub>o(er)</sub>	$V_{GS} = 0V$ $V_{DS} = 0V$ to 500V	-	71	-	pF
Turn - on delay time	t <sub>d(on)</sub> *4	$V_{DD} = 400 V, I_{D} = 7 A$	-	23	ı	
Rise time	t <sub>r</sub> *4	$V_{GS} = 18V/0V$	-	25	ı	ns
Turn - off delay time	t <sub>d(off)</sub> *4	$R_L = 57\Omega$	-	67	ı	115
Fall time	t <sub>f</sub> *4	$R_G = 0\Omega$	-	27	ı	
Turn - on switching loss	E <sub>on</sub> *4	$V_{DD} = 600V, I_{D} = 7A$ $V_{GS} = 18V/0V$	-	126	-	1
Turn - off switching loss	E <sub>off</sub> *4	$R_G = 0\Omega$ , L=500 $\mu$ H * $E_{on}$ includes diode reverse recovery	-	55	-	μJ

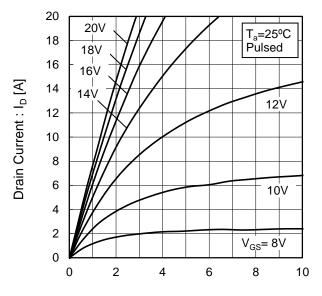
# •Gate Charge characteristics $(T_a = 25^{\circ}C)$

Parameter	Symbol	Conditions	Values			Unit
			Min.	Тур.	Max.	Offic
Total gate charge	$Q_g^{*4}$	V <sub>DD</sub> = 400V	-	62	ı	
Gate - Source charge	Q <sub>gs</sub> *4	I <sub>D</sub> = 7A	-	14	-	nC
Gate - Drain charge	${\sf Q_{gd}}^{^{*4}}$	V <sub>GS</sub> = 18V	ı	20	ı	
Gate plateau voltage	$V_{(plateau)}$	$V_{DD} = 400V, I_{D} = 7A$	-	9.6	ı	V

# ullet Body diode electrical characteristics (Source-Drain) (T<sub>a</sub> = 25°C)

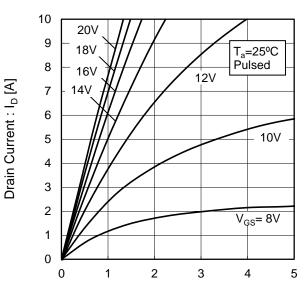
Parameter	Symbol	Conditions	Values			Unit
			Min.	Тур.	Max.	Offit
Inverse diode continuous, forward current	l <sub>S</sub> *1	T <sub>c</sub> = 25°C	ı	ı	22	А
Inverse diode direct current, pulsed	I <sub>SM</sub> *2			-	55	А
Forward voltage	V <sub>SD</sub> *4	$V_{GS} = 0V$ , $I_S = 7A$	-	4.1	-	V
Reverse recovery time	t <sub>rr</sub> *4	I <sub>F</sub> = 7A, V <sub>R</sub> = 400V di/dt = 160A/μs	ı	26	ı	ns
Reverse recovery charge	Q <sub>rr</sub> *4		-	39	-	nC
Peak reverse recovery current	I <sub>rrm</sub> *4		-	3.0	-	Α

Fig.1 Typical Output Characteristics(I)



Drain - Source Voltage : V<sub>DS</sub> [V]

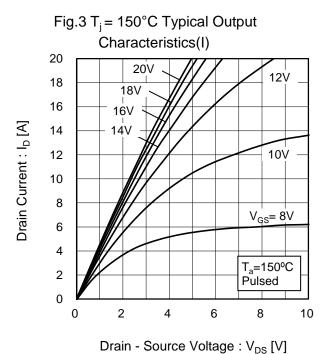
Fig.2 Typical Output Characteristics(II)



Drain - Source Voltage : V<sub>DS</sub> [V]

Fig.4  $T_j$  = 150°C Typical Output

Characteristics(II)



10

0 1 2 3 4

Drain - Source Voltage : V<sub>DS</sub> [V]

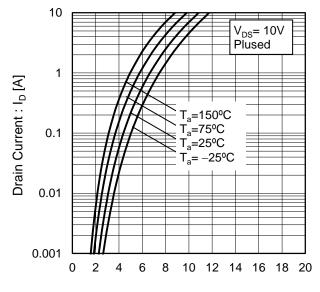
10V

 $V_{GS} = 8V$ 

T<sub>a</sub>=150°C

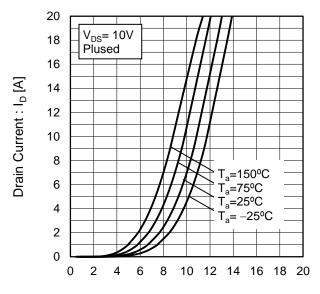
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Fig.5 Typical Transfer Characteristics (I)



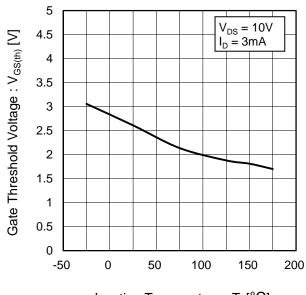
Gate - Source Voltage : V<sub>GS</sub> [V]

Fig.6 Typical Transfer Characteristics (II)



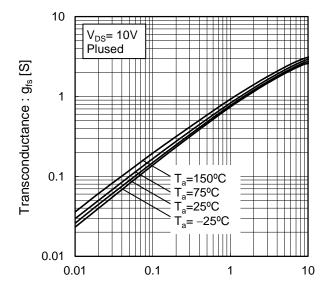
Gate - Source Voltage : V<sub>GS</sub> [V]

Fig.7 Gate Threshold Voltage vs. Junction Temperature



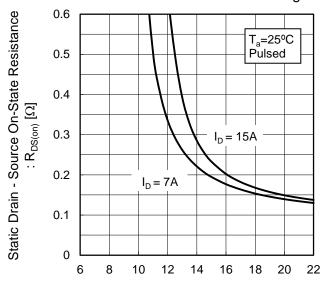
Junction Temperature :  $T_j$  [°C]

Fig.8 Transconductance vs. Drain Current



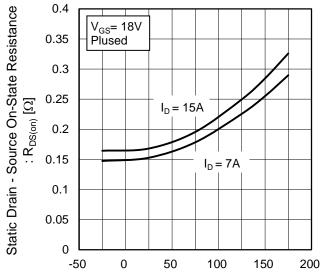
Drain Current : I<sub>D</sub> [A]

Fig.9 Static Drain - Source On - State Resistance vs. Gate Source Voltage



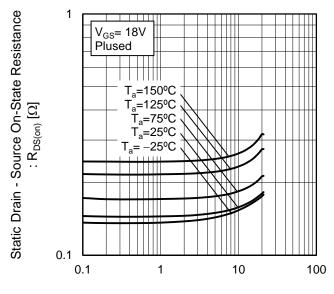
Gate - Source Voltage : V<sub>GS</sub> [V]

Fig.10 Static Drain - Source On - State Resistance vs. Junction Temperature



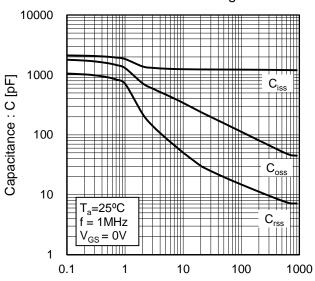
Junction Temperature : T<sub>i</sub> [°C]

Fig.11 Static Drain - Source On - State Resistance vs. Drain Current



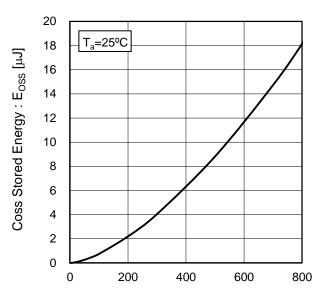
Drain Current : I<sub>D</sub> [A]

Fig.12 Typical Capacitance vs. Drain - Source Voltage



Drain - Source Voltage : V<sub>DS</sub> [V]

Fig.13 Coss Stored Energy



Drain - Source Voltage : V<sub>DS</sub> [V]

Fig.14 Switching Characteristics

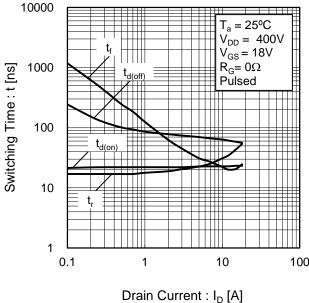
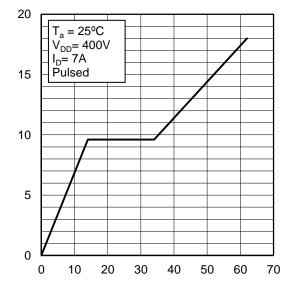
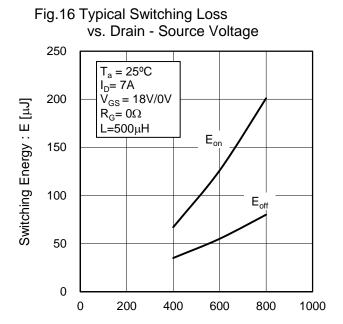


Fig.15 Dynamic Input Characteristics



Total Gate Charge : Q<sub>g</sub> [nC]

Gate - Source Voltage : V<sub>GS</sub> [V]



Drain - Source Voltage : V<sub>DS</sub> [V]

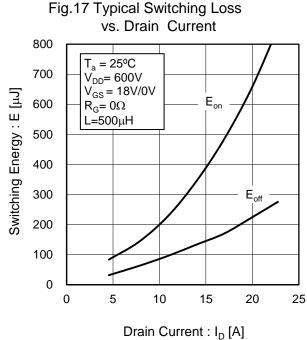
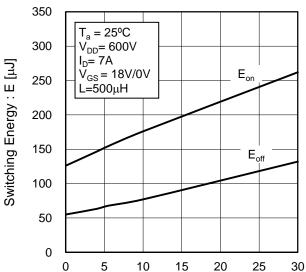


Fig.18 Typical Switching Loss vs. External Gate Resistance



External Gate Resistance :  $R_G [\Omega]$ 

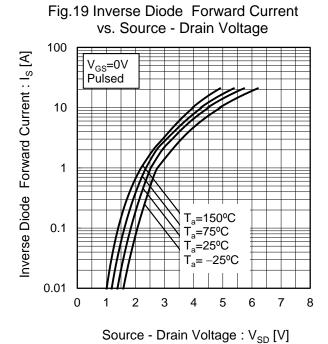
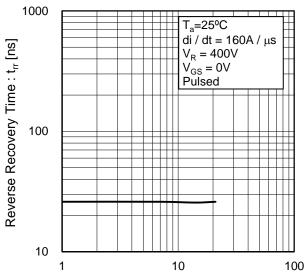


Fig.20 Reverse Recovery Time vs.Inverse Diode Forward Current



Inverse Diode Forward Current : I<sub>S</sub> [A]

### ●Measurement circuits

Fig.1-1 Switching Time Measurement Circuit

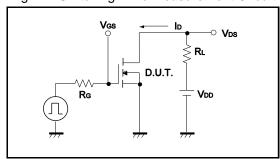


Fig.2-1 Gate Charge Measurement Circuit

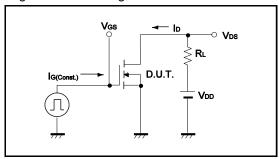


Fig.3-1 Switching Energy Measurement Circuit

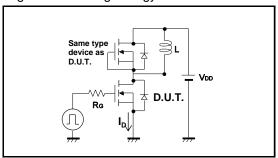


Fig.4-1 Reverse Recovery Time Measurement Circuit Fig.4-2 Reverse Recovery Waveform

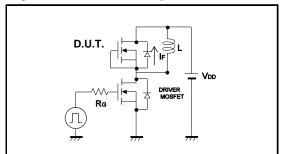


Fig.1-2 Switching Waveforms

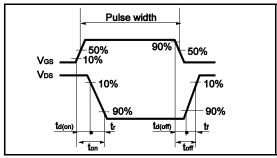


Fig.2-2 Gate Charge Waveform

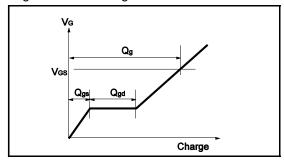
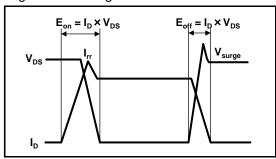
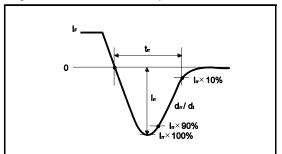


Fig.3-2 Switching Waveforms





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